

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination PATADIA ET AL.	
		Examiner Andrea N. Long	Art Unit 2176	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,987,469 A	11-1999	Lewis et al.	707/102
*	B	US-5,987,611 A	11-1999	Freund, Gregor	726/4
*	C	US-6,055,515 A	04-2000	Consentino et al.	705/27
*	D	US-2001/0034771 A1	10-2001	Hutsch et al.	709/217
*	E	US-6,430,556 B1	08-2002	Goldberg et al.	707/4
*	F	US-6,466,239 B2	10-2002	Ishikawa, Masayuki	715/850
*	G	US-2002/0147696 A1	10-2002	ACKER et al.	707/1
*	H	US-6,581,071 B1	06-2003	Gustman et al.	707/104.1
*	I	US-2003/0204481 A1	10-2003	Lau, Christina P.	707/1
*	J	US-2003/0216938 A1	11-2003	Shour, Shimon	705/2
*	K	US-2004/0024812 A1	02-2004	Park et al.	709/203
*	L	US-6,834,284 B2	12-2004	Acker et al.	707/103R
*	M	US-2005/0198617 A1	09-2005	Kim et al.	717/109

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Emmanuel Tanyi□□Easy XML□□06 Mar 2000□□www.winsite.com□□pages 1-6
	V	Method and System for Visually Constructing Document Type Definitions and Related Artifacts Using a Reusable Object Model□□IBM Technical Disclosure Bulletin□□May 23, 2001
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination PATADIA ET AL.	
		Examiner Andrea N. Long	Art Unit 2176	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0087571 A1	07-2002	Stapel et al.	707/100
*	B	US-2002/0120685 A1	08-2002	Srivastava et al.	709/203
*	C	US-2002/0143819 A1	10-2002	Han et al.	707/513
*	D	US-2003/0120686 A1	06-2003	Kim et al.	707/200
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.